


<b>Search Notes</b>  	<b>Application/Control No.</b>  10676873	<b>Applicant(s)/Patent Under Reexamination</b>  CHAN ET AL.
	<b>Examiner</b>  ERIC S DEJONG	<b>Art Unit</b>  1631

SEARCHED			
Class	Subclass	Date	Examiner
none			

SEARCH NOTES		
Search Notes	Date	Examiner
See previous search history printout of 11/02/2005	07/14/2008	EDJ
Inventor Search Updated in PALM	07/14/2008	EDJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner